

Seeing Far in the Dark with Patterned Flash



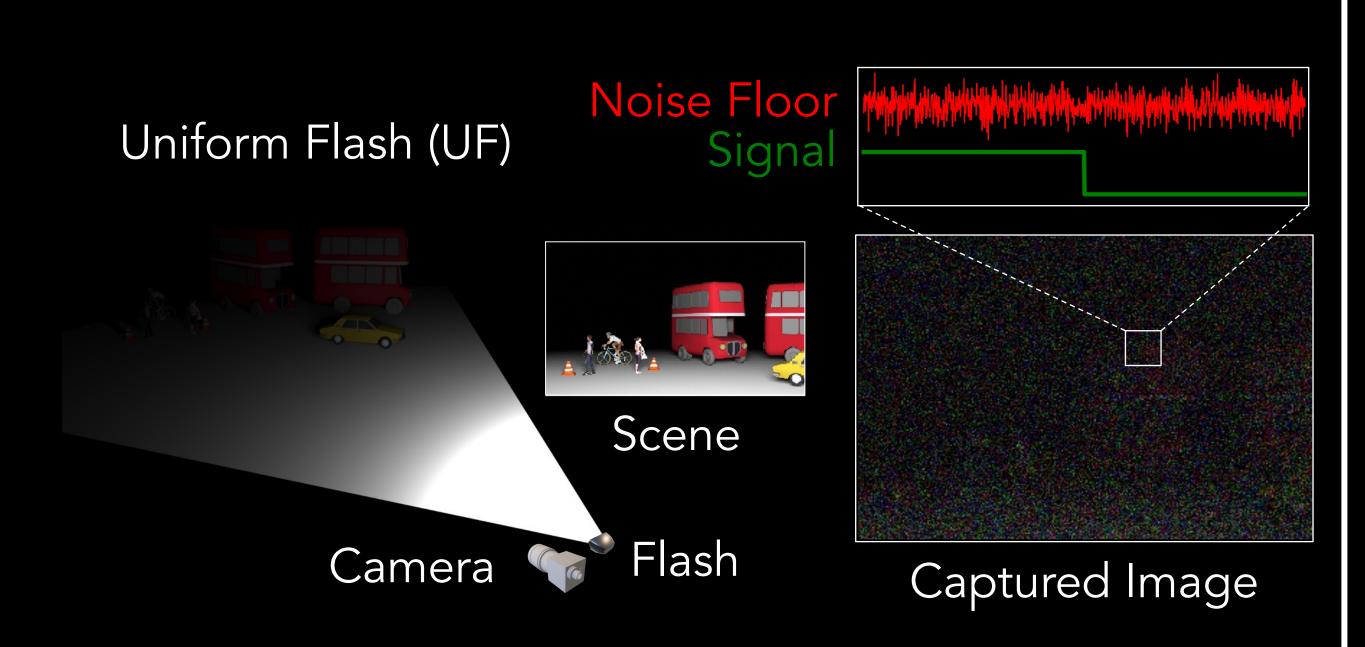
Ground-Truth

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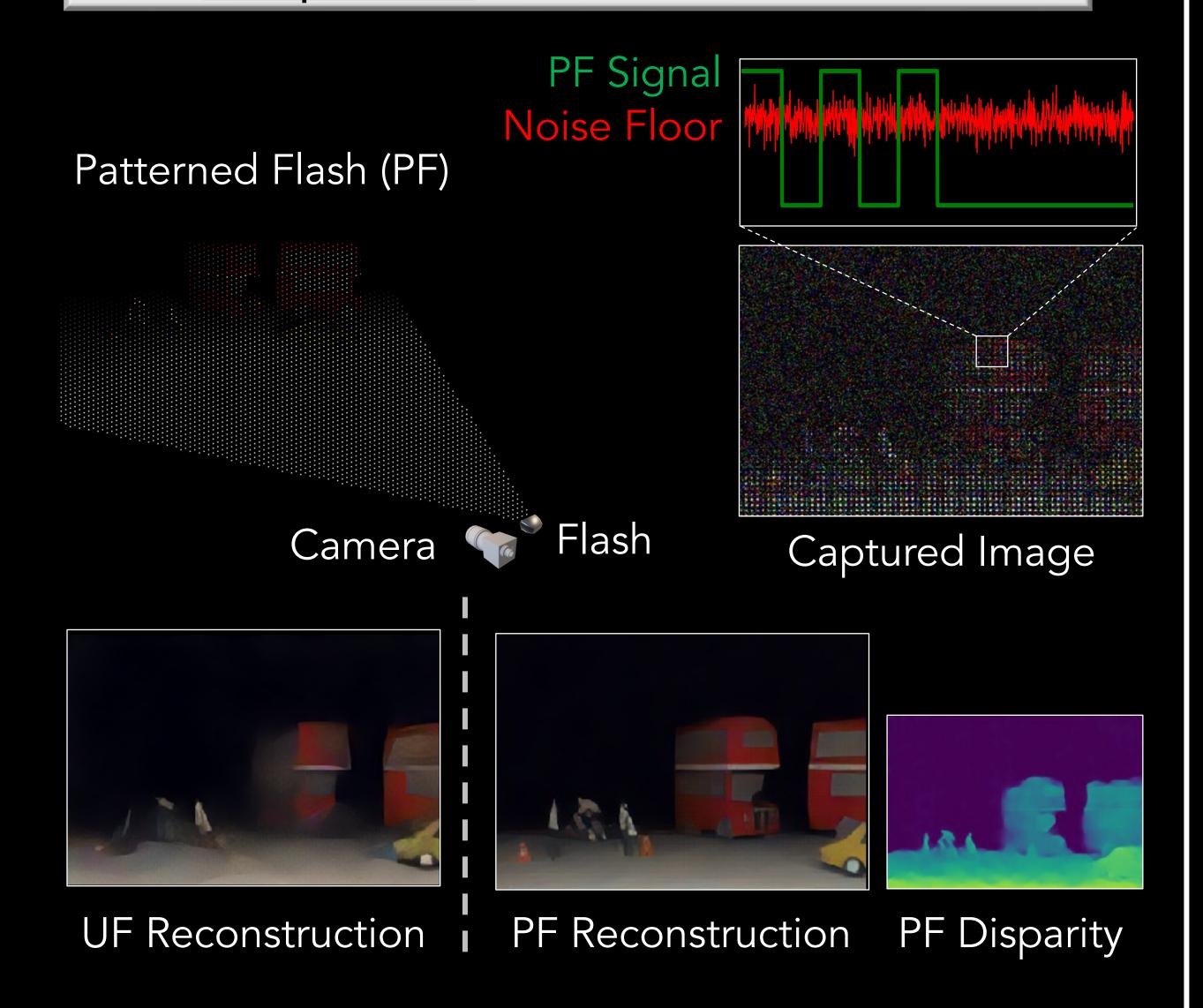
Code and data: https://github.com/zhsun0357/Seeing-Far-in-the-Dark-with-Patterned-Flash

Problem in the Traditional Flash



- Physical law: light falls off with 1/depth²
- Flash is limited in distance
- o Flash signal is overwhelmed by sensor noise

Proposed: Patterned Flash

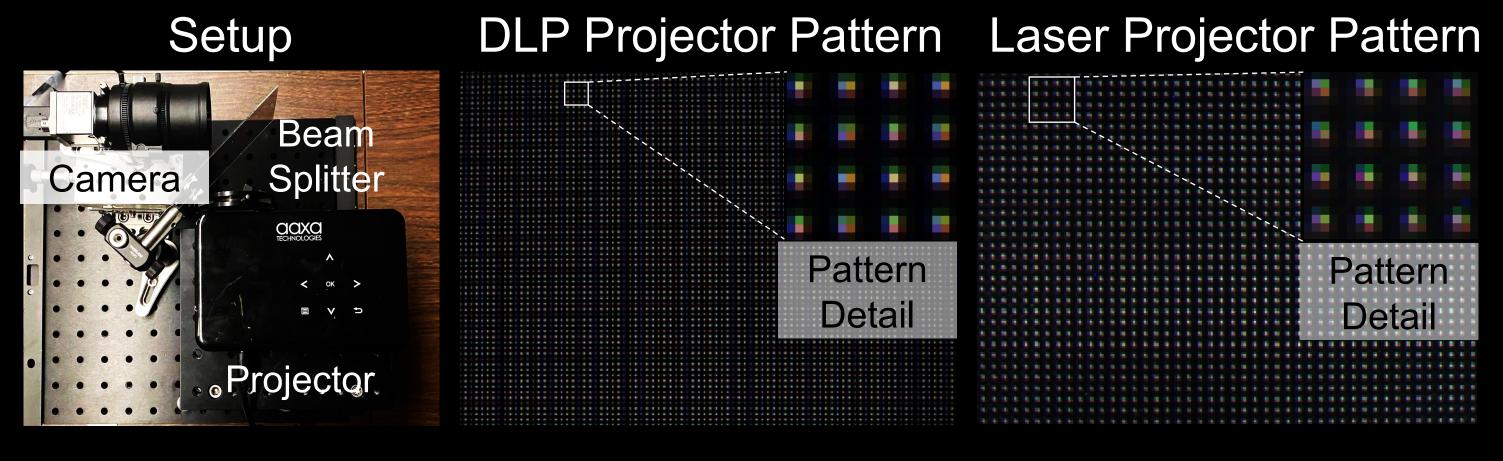


- PF concentrates light into a dot array for higher signal-noise ratio at dots' location
- PF is also a structured light system that supports depth estimation

Algorithm PF Image Estimated Color Image Res-UNet Reference Pattern Estimated Disparity PSNR SSIM LPIPS Disparity MAE 28 26 24 26 27 28 29 29 29 20 20 20 20 20 20 21 214 16 18 20 214 16 18 215 Distance Distance Distance Distance Distance

- Joint image reconstruction & depth estimation
- In simulations
 - o PF achieves better image restoration quality
- o PF achieves sub-pixel disparity accuracy for depth est.

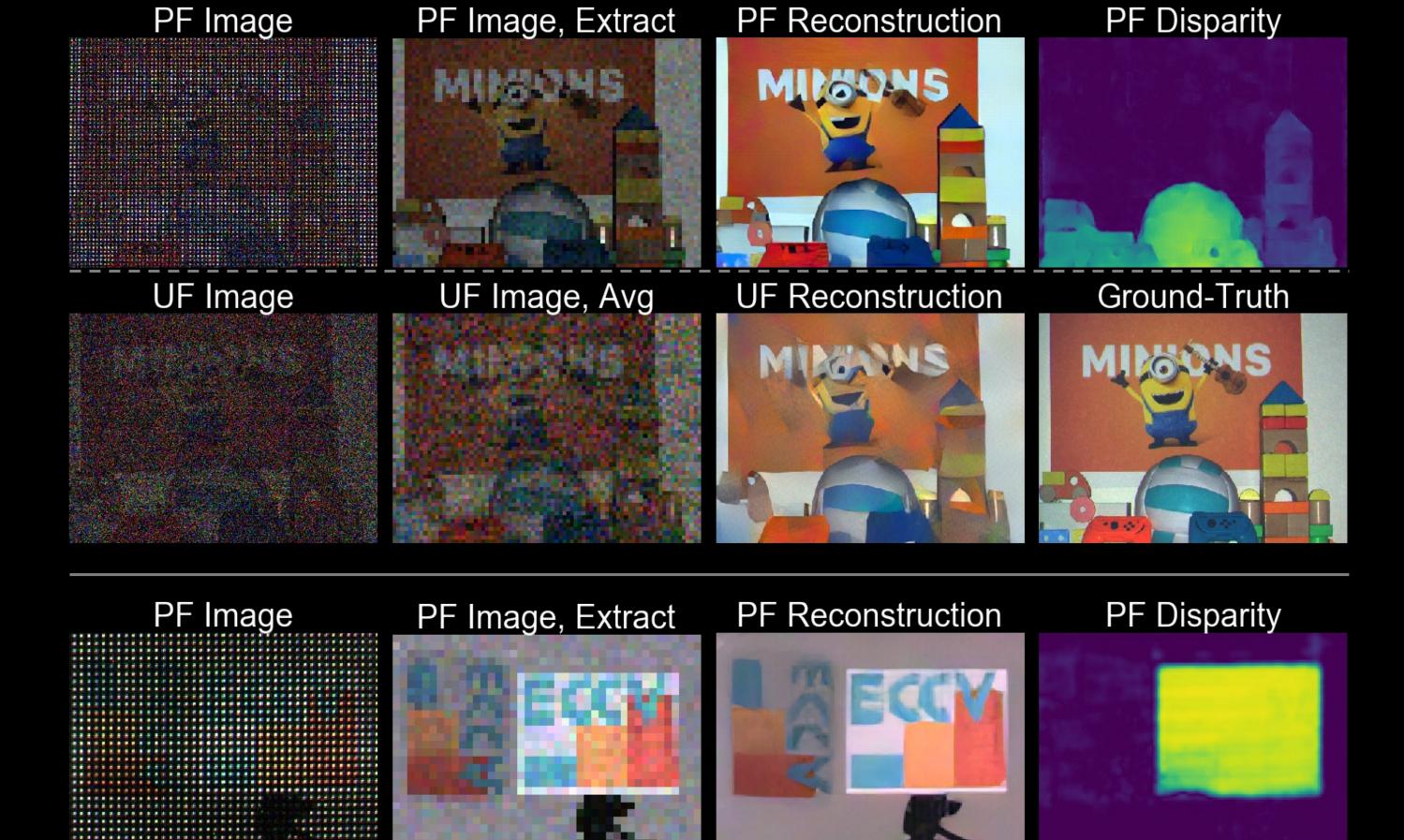
Hardware Prototype



- Setup: camera, projector, beam splitter (for easily adjusting baseline only)
- Regular pattern vs. random pattern
 The former one has better image restoration quality
- DLP projector is used to emulate the PF and UF
- Laser projector has no light loss, but has low power

Image Restoration

• PF resolves fine details and avoids reconstruction artifacts compared to UF; additionally, PF has depth



Applications

UF Reconstruction

UF Image, Avg

UF Image

UF Captured PF Captured UF Detection PF Detection

Output

Out

- Low-light imaging (can be extended to other modalities, like IR, UV, hyper-spectral imaging)
- High-level tasks in low-light env., like face/car detection
- Single-shot flash/no-flash imaging; 3D-based background blurring
- PF hardware implementations: MEMS scanner, VCSEL array, diffractive optical element (DOE), ...